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# **BUK724R5-30C**

# N-channel TrenchMOS standard level FET

Rev. 01 — 1 July 2010

**Product data sheet** 

### 1. Product profile

#### 1.1 General description

Standard level gate drive N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using advanced TrenchMOS technology. This product has been designed and qualified to the appropriate AEC standard for use in high performance automotive applications.

#### 1.2 Features and benefits

- AEC Q101 compliant
- Avalanche robust

- Suitable for standard level gate drive
- Suitable for thermally demanding environment up to 175°C rating

### 1.3 Applications

- 12V Motor, lamp and solenoid loads
- High performance automotive power systems
- High performance Pulse Width Modulation (PWM) applications

#### 1.4 Quick reference data

Table 1. Quick reference data

	_	6 IIII			_		
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
$V_{DS}$	drain-source voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}$		-	-	30	V
$I_D$	drain current	$V_{GS} = 10 \text{ V}; T_j = 25 \text{ °C};$ see <u>Figure 1</u>	[1]	-	-	75	Α
P <sub>tot</sub>	total power dissipation	$T_{mb} = 25  ^{\circ}\text{C}$ ; see Figure 2		-	-	157	W
Static chara	acteristics						
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A};$ $T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure 12}}{\text{Figure 13}};$		-	3.8	4.5	mΩ
Avalanche	ruggedness						
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy	$I_D = 75$ A; $V_{sup} \le 30$ V; $R_{GS} = 50$ $\Omega$ ; $V_{GS} = 10$ V; $T_{j(init)} = 25$ °C; unclamped		-	-	329	mJ
Dynamic characteristics							
$Q_{GD}$	gate-drain charge	$V_{GS} = 10 \text{ V; } I_D = 25 \text{ A;}$ $V_{DS} = 24 \text{ V; } T_j = 25 \text{ °C;}$ see Figure 14		-	21	-	nC



[1] Continuous current is limited by package.

# 2. Pinning information

Table 2. Pinning information

Pin Symbol Description Simplified outline Graphic symbol  1 G gate 2 D drain[1] 3 S source mb D mounting base; connected to drain  SOT428 (DPAK)		•			
2 D drain[1] 3 S source mb D mounting base; connected to drain	Pin	Symbol	Description	Simplified outline	Graphic symbol
3 S source mb D mounting base; connected to drain  1 3	1	G	gate		_
mb D mounting base; connected to drain  G Mbb076 S  mbb076 S	2	D	drain[1]	mb	D D
drain mbb076 \$	3	S	source		
SOT428 (DPAK)	mb	D			mbb076 S
·				SOT428 (DPAK)	

<sup>[1]</sup> It is not possible to make connection to pin 2.

# 3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
BUK724R5-30C	DPAK	plastic single-ended surface-mounted package (DPAK); 3 leads (one lead cropped)	SOT428

### 4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
$V_{DS}$	drain-source voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C		-	-	30	V
$V_{DGR}$	drain-gate voltage	$R_{GS} = 20 \text{ k}\Omega$		-	-	30	V
V <sub>GS</sub>	gate-source voltage			-20	-	20	V
I <sub>D</sub>	drain current	$V_{GS} = 10 \text{ V}; T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure 1}}{\text{see } \frac{\text{Figure 4}}{\text{Figure 4}}};$	<u>[1]</u>	-	-	136	Α
		$T_{mb}$ = 100 °C; $V_{GS}$ = 10 V; see <u>Figure 1</u>	[2]	-	-	75	Α
		$V_{GS} = 10 \text{ V}; T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure 1}}{}$	[2]	-	-	75	Α
I <sub>DM</sub>	peak drain current	$t_p \le 10  \mu\text{s}; \text{ pulsed}; T_j = 25 ^\circ\text{C};$ see Figure 4		-	-	543	Α
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>		-	-	157	W
T <sub>stg</sub>	storage temperature			-55	-	175	°C
T <sub>j</sub>	junction temperature			-55	-	175	°C
Source-drain	diode						
I <sub>S</sub>	source current	T <sub>mb</sub> = 25 °C	[2]	-	-	75	Α
			[1]	-	-	136	Α
I <sub>SM</sub>	peak source current	$t_p \le 10 \ \mu s$ ; pulsed; $T_{mb} = 25 \ ^{\circ}C$		-	-	543	Α
Avalanche rug	gedness						
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy	$I_D$ = 75 A; $V_{sup} \le 30$ V; $R_{GS}$ = 50 $\Omega$ ; $V_{GS}$ = 10 V; $T_{j(init)}$ = 25 °C; unclamped		-	-	329	mJ
E <sub>DS(AL)R</sub>	repetitive drain-source avalanche energy	see Figure 3	[3][4][5]	-	-	-	J

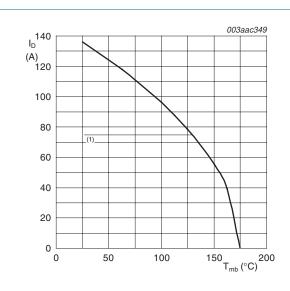
<sup>[1]</sup> Current is limited by power dissipation chip rating.

<sup>[2]</sup> Continuous current is limited by package.

<sup>[3]</sup> Single-pulse avalanche rating limited by maximum junction temperature of 175 °C.

<sup>[4]</sup> Repetitive avalanche rating limited by average junction temperature of 170 °C.

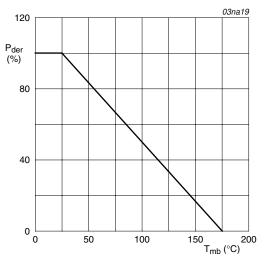
<sup>[5]</sup> Refer to application note AN10273 for further information.



 $V_{\rm GS} \geq 5\,V$ 

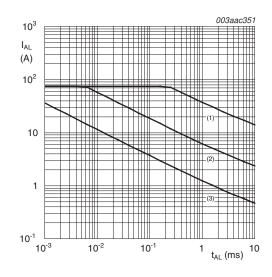
(1) Capped at 75 A due to package. Fig 1. Continuous drain current as a function of

mounting base temperature



$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100 \%$$

Normalized total power dissipation as a Fig 2. function of mounting base temperature

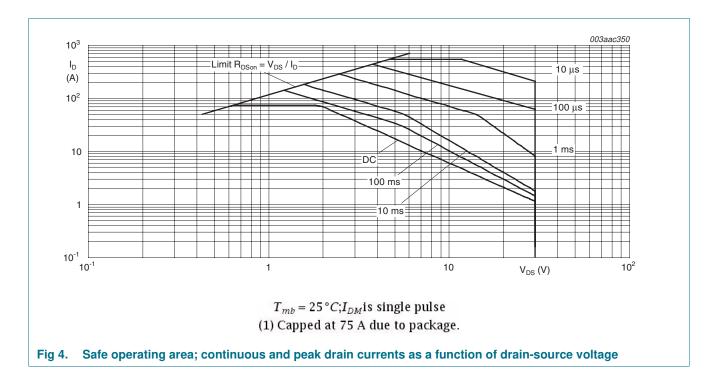


(1) Single-pulse;  $T_j = 25 \,^{\circ}C$ .

(2) Single-pulse;  $T_j = 150 \,^{\circ}C$ .

(3) Repetitive.

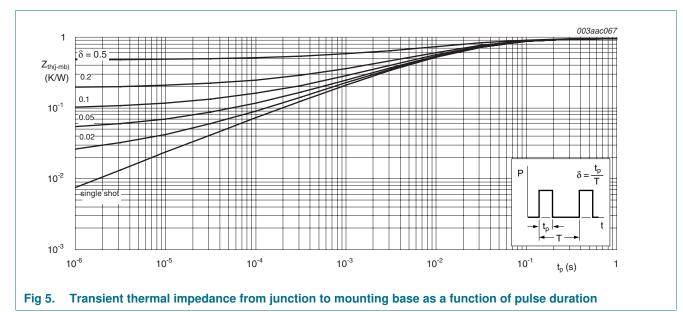
Single-pulse and repetitive avalanche rating; avalanche current as a function of avalanche time Fig 3.



### 5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	see Figure 5	-	0.65	0.95	K/W
R <sub>th(j-a)</sub>	thermal resistance from junction to ambient		-	70	-	K/W



BUK724R5-30C

# 6. Characteristics

Table 6. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static char	acteristics					
V <sub>(BR)DSS</sub>	drain-source	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	30	-	-	V
	breakdown voltage	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = -55 \text{ °C}$	27	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = 25$ °C; see <u>Figure 10</u> ; see <u>Figure 11</u>	2	3	4	V
		$I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = 175$ °C; see <u>Figure 10</u>	1	-	-	V
		$I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = -55$ °C; see <u>Figure 10</u>	-	-	4.4	V
I <sub>DSS</sub>	drain leakage current	$V_{DS} = 30 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 ^{\circ}\text{C}$	-	-	500	μΑ
		$V_{DS} = 30 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.02	1	μΑ
I <sub>GSS</sub>	gate leakage current	$V_{DS} = 0 \text{ V}; V_{GS} = 20 \text{ V}; T_j = 25 \text{ °C}$	-	2	100	nΑ
		$V_{DS} = 0 \text{ V}; V_{GS} = -20 \text{ V}; T_j = 25 \text{ °C}$	-	2	100	nA
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 175 \text{ °C};$ see Figure 12	-	-	8.5	mΩ
		$V_{GS}$ = 10 V; $I_D$ = 25 A; $T_j$ = 25 °C; see <u>Figure 12</u> ; see <u>Figure 13</u>	-	3.8	4.5	mΩ
Dynamic c	haracteristics					
Q <sub>G(tot)</sub>	total gate charge	$I_D = 25 \text{ A}; V_{DS} = 24 \text{ V}; V_{GS} = 10 \text{ V};$ $T_j = 25 ^{\circ}\text{C}; \text{ see } \frac{\text{Figure } 14}{\text{Figure } 14}$	-	62	-	nC
$Q_{GS}$	gate-source charge	$I_D = 25 \text{ A}; V_{DS} = 24 \text{ V}; V_{GS} = 10 \text{ V};$ $T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure } 14}{\text{Figure } 14}$	-	14	-	nC
$Q_{GD}$	gate-drain charge	$I_D = 25 \text{ A}; V_{DS} = 24 \text{ V}; V_{GS} = 10 \text{ V};$ $T_j = 25 ^{\circ}\text{C}; \text{ see } \frac{\text{Figure } 14}{\text{Figure } 14}$	-	21	-	nC
C <sub>iss</sub>	input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz};$	-	2820	3760	pF
C <sub>oss</sub>	output capacitance	T <sub>j</sub> = 25 °C; see <u>Figure 15</u>	-	670	804	pF
$C_{rss}$	reverse transfer capacitance		-	422	580	pF
d(on)	turn-on delay time	$V_{DS}$ = 25 V; $R_L$ = 1 $\Omega$ ; $V_{GS}$ = 10 V; $R_{G(ext)}$ = 10 $\Omega$ ; $T_j$ = 25 °C	-	24	-	ns
r	rise time	$V_{DS} = 25 \text{ V}; R_L = 1 \Omega; V_{GS} = 10 \text{ V}; R_{G(ext)} 10 \Omega; T_j = 25 \text{ °C}$	-	51	-	ns
d(off)	turn-off delay time	$V_{DS} = 25 \text{ V}; R_L = 1 \Omega; V_{GS} = 10 \text{ V};$	-	85	-	ns
f	fall time	$R_{G(ext)} = 10 \Omega; T_j = 25 °C$	-	62	-	ns
-D	internal drain inductance	measured from drain to centre of die ; $T_j = 25\ ^{\circ}\text{C}$	-	2.5	-	nΗ
L <sub>S</sub>	internal source inductance	measured from source lead to source bond pad; $T_i = 25$ °C	-	7.5	-	nΗ

Table 6. Characteristics ... continued

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Source-drai	n diode					
V <sub>SD</sub>	source-drain voltage	$I_S = 20 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C};$ see <u>Figure 16</u>	-	0.85	1.2	V
t <sub>rr</sub>	reverse recovery time	$I_S = 20 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s};$	-	40	-	ns
Q <sub>r</sub>	recovered charge	$V_{GS} = -10 \text{ V}; V_{DS} = 25 \text{ V}; T_j = 25 \text{ °C}$	-	44	-	nC

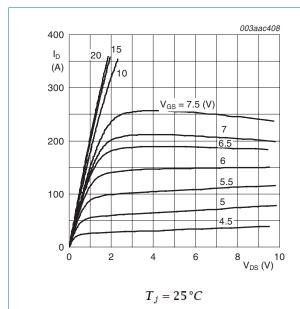


Fig 6. Output characteristics: drain current as a function of drain-source voltage; typical values

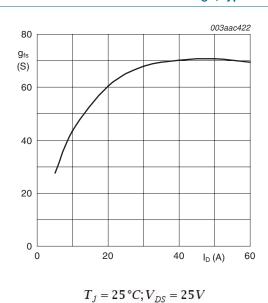


Fig 8. Forward transconductance as a function of drain current; typical values

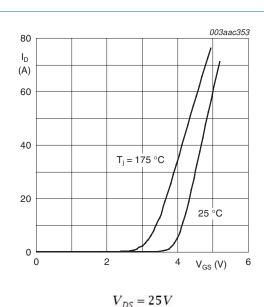
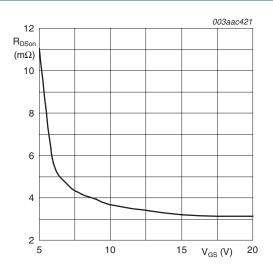


Fig 7. Transfer characteristics: drain current as a function of gate-source voltage; typical values



 $T_j=25\,^{\circ}C; I_D=15A$ 

Fig 9. Drain-source on-state resistance as a function of gate-source voltage; typical values

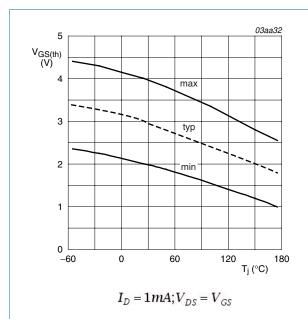
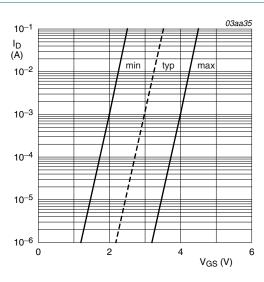


Fig 10. Gate-source threshold voltage as a function of junction temperature



 $T_j = 25 \,^{\circ}C; V_{DS} = 5V$ 

Fig 11. Sub-threshold drain current as a function of gate-source voltage

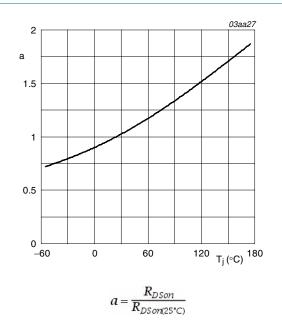


Fig 12. Normalized drain-source on-state resistance factor as a function of junction temperature

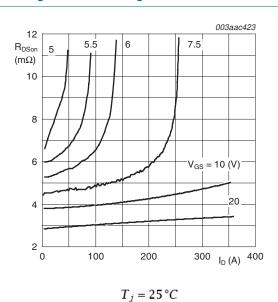


Fig 13. Drain-source on-state resistance as a function of drain current; typical values

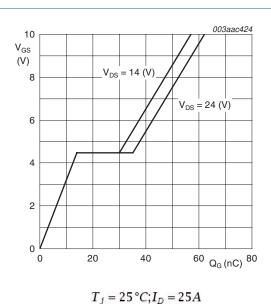
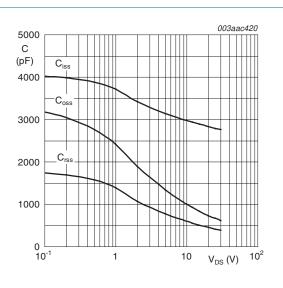
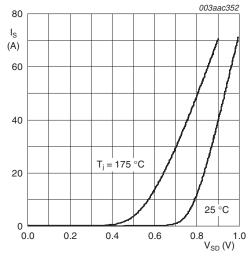


Fig 14. Gate-source voltage as a function of gate charge; typical values



 $V_{GS} = 0V; f = 1MHz$ 

Fig 15. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values



 $V_{GS} = 0V$ 

Fig 16. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values

### 7. Package outline

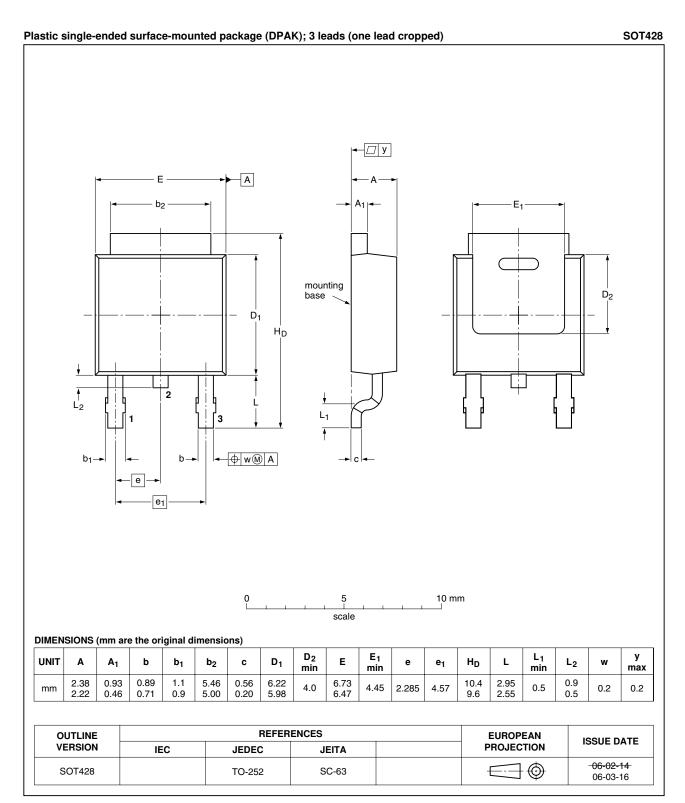


Fig 17. Package outline SOT428 (DPAK)

**BUK724R5-30C** 

#### N-channel TrenchMOS standard level FET

# **Revision history**

#### Table 7. **Revision history**

Document ID	Release date	Data sheet status	Change notice	Supersedes
BUK724R5-30C v.1	20100701	Product data sheet	-	-

### 9. Legal information

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Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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#### N-channel TrenchMOS standard level FET

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